

GTC220E

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

BVDSS	20V
RDS(ON)	30mΩ
ID	5A

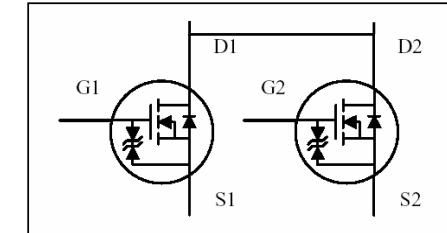
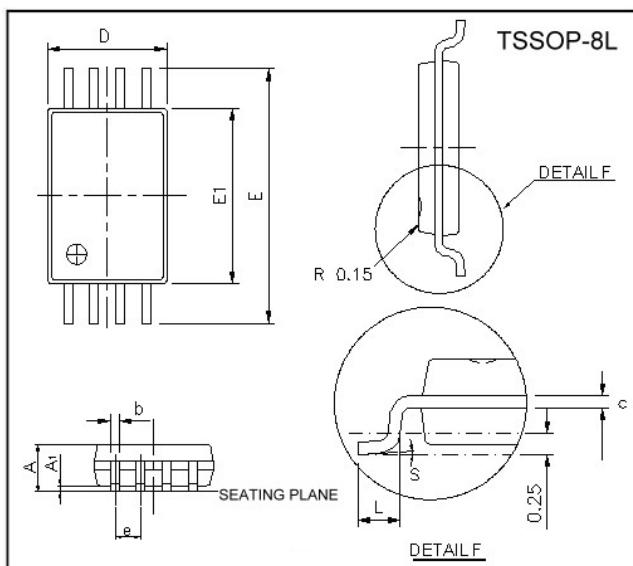
Description

The GTC220E provides the designer with the best combination of fast switching, ruggedized device design, ultra low on-resistance and cost-effectiveness.

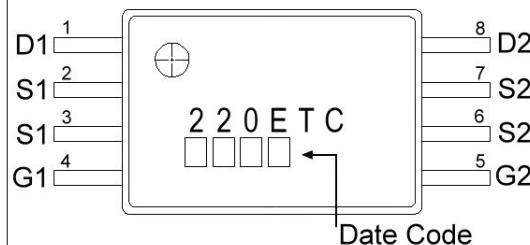
Features

- *Low on-resistance
- *Capable of 2.5V gate drive
- *Low drive current
- *Surface mount package

Package Dimensions



Marking :



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	-	1.20	E	6.20	6.60
A1	0.05	0.15	E1	4.30	4.50
b	0.19	0.30	e	0.65 BSC	
c	0.09	0.20	L	0.45	0.75
D	2.90	3.10	S	0°	8°

Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	20	V
Gate-Source Voltage	V _{GS}	±12	V
Continuous Drain Current ³ , V _{GS} @10V	I _D @Ta=25°C	5.0	A
Continuous Drain Current ³ , V _{GS} @10V	I _D @Ta=70°C	4.0	A
Pulsed Drain Current ^{1,2}	I _{DM}	20	A
Total Power Dissipation	P _D @Ta=25°C	1	W
Linear Derating Factor		0.008	W/°C
Operating Junction and Storage Temperature Range	T _j , T _{stg}	-55 ~ +150	°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-ambient Max.	R _{thj-a}	125	°C/W

Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	20	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	0.1	-	V/ $^\circ\text{C}$	Reference to 25°C , $\text{I}_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	0.5	-	-	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$
Forward Transconductance	g_{fs}	-	9.7	-	S	$\text{V}_{\text{DS}}=10\text{V}, \text{I}_D=4.6\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 10	μA	$\text{V}_{\text{GS}}= \pm 12\text{V}$
Drain-Source Leakage Current($T_j=25^\circ\text{C}$)	I_{DSS}	-	-	1	μA	$\text{V}_{\text{DS}}=20\text{V}, \text{V}_{\text{GS}}=0$
Drain-Source Leakage Current($T_j=70^\circ\text{C}$)		-	-	25	μA	$\text{V}_{\text{DS}}=20\text{V}, \text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance	$\text{R}_{\text{DS}(\text{ON})}$	-	-	30	$\text{m}\Omega$	$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=5\text{A}$
		-	-	40		$\text{V}_{\text{GS}}=2.5\text{V}, \text{I}_D=3\text{A}$
Total Gate Charge ²	Q_g	-	12.5	-	nC	$\text{I}_D=4.6\text{A}$ $\text{V}_{\text{DS}}=20\text{V}$ $\text{V}_{\text{GS}}=5\text{V}$
Gate-Source Charge	Q_{gs}	-	1	-		
Gate-Drain ("Miller") Change	Q_{gd}	-	6.5	-		
Turn-on Delay Time ²	$\text{T}_{\text{d}(\text{on})}$	-	5	-	Ns	$\text{V}_{\text{DS}}=10\text{V}$ $\text{I}_D=1\text{A}$ $\text{V}_{\text{GS}}=5\text{V}$ $\text{R}_G=3.3\Omega$ $\text{R}_D=10\Omega$
Rise Time	T_r	-	9	-		
Turn-off Delay Time	$\text{T}_{\text{d}(\text{off})}$	-	26.2	-		
Fall Time	T_f	-	6.8	-		
Input Capacitance	C_{iss}	-	355	-	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=20\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	190	-		
Reverse Transfer Capacitance	C_{rss}	-	85	-		

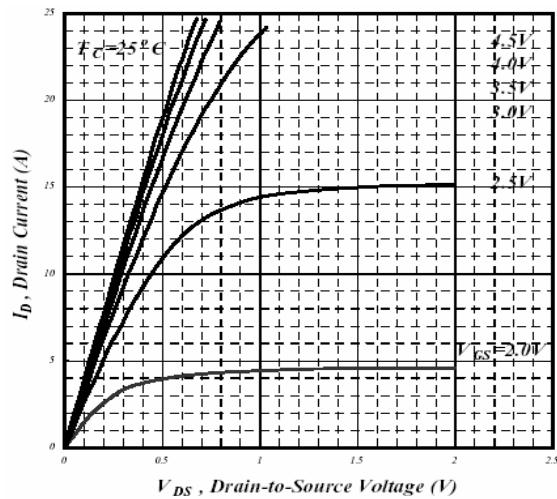
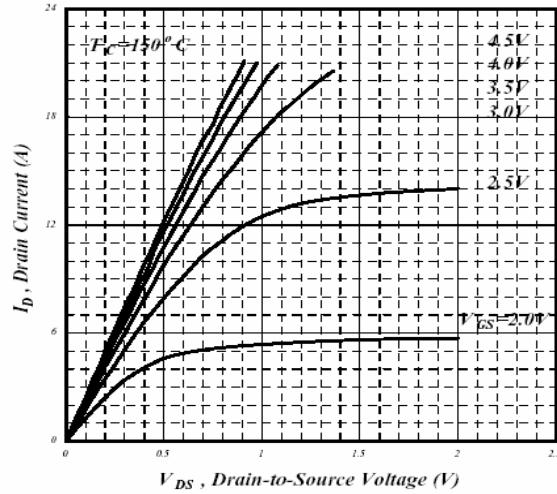
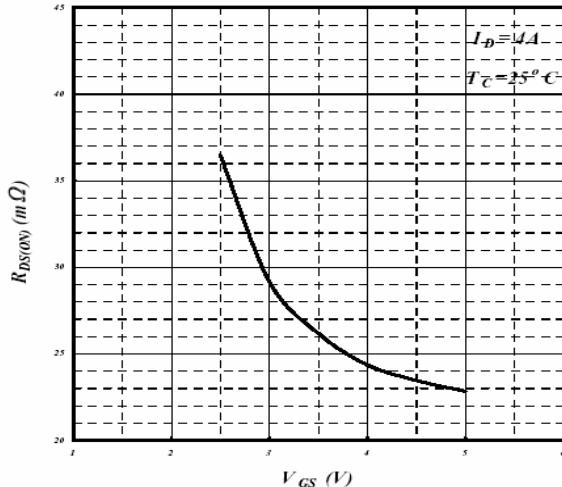
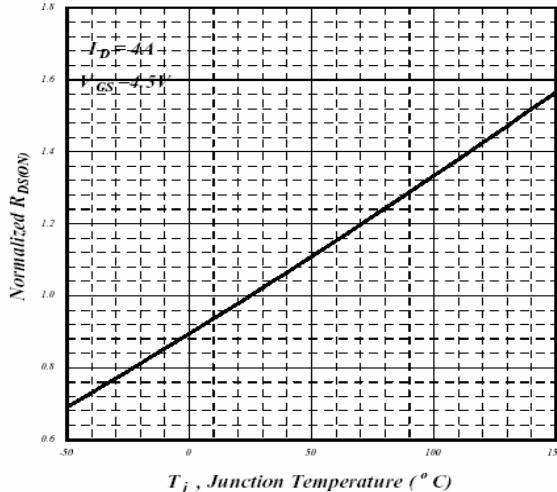
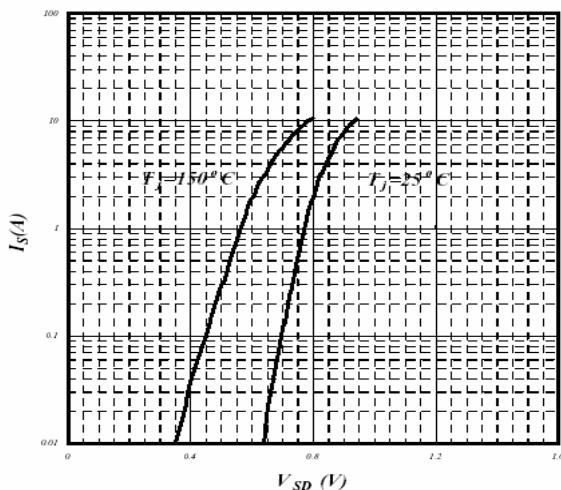
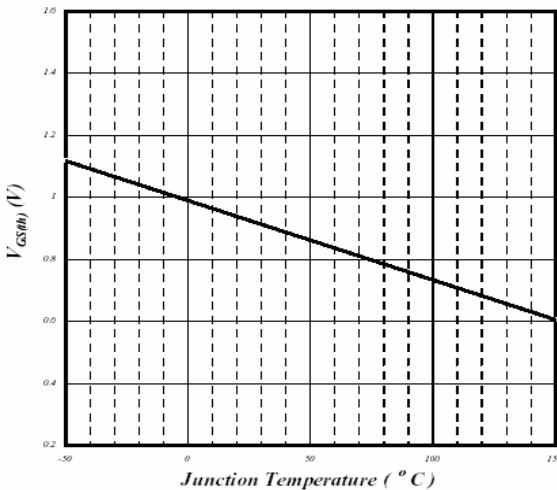
Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ²	V_{SD}	-	-	1.2	V	$\text{I}_S=1.25, \text{V}_{\text{GS}}=0\text{V}, \text{T}_j=25^\circ\text{C}$
Continuous Source Current(Body Diode)	I_S	-	-	1.25	A	$\text{V}_D= \text{V}_G=0\text{V}, \text{V}_S=1.2\text{V}$
Continuous Source Current(Body Diode) ¹	I_{SM}	-	-	20	A	

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.

3. Surface mounted on FR4 board, $t \leq 10\text{sec}$.

Characteristics Curve**Fig 1. Typical Output Characteristics****Fig 2. Typical Output Characteristics****Fig 3. On-Resistance v.s. Gate Voltage****Fig 4. Normalized On-Resistance v.s. Junction Temperature****Fig 5. Forward Characteristics of Reverse Diode****Fig 6. Gate Threshold Voltage v.s. Junction Temperature**

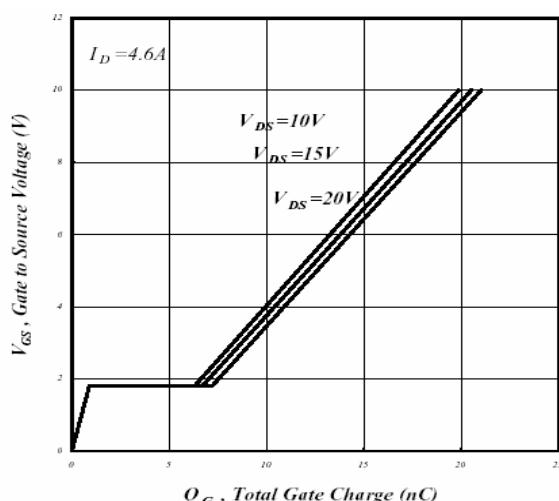


Fig 7. Gate Charge Characteristics

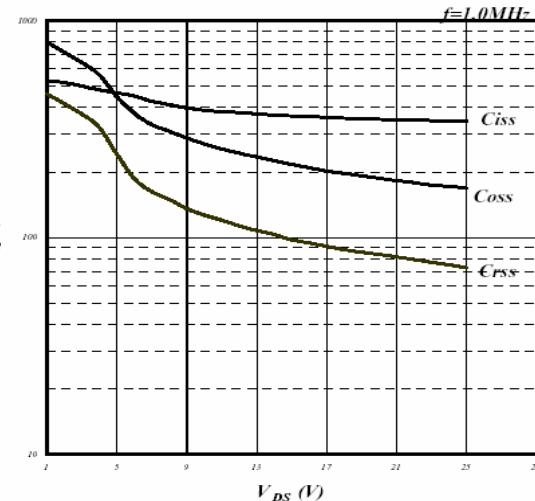


Fig 8. Typical Capacitance Characteristics

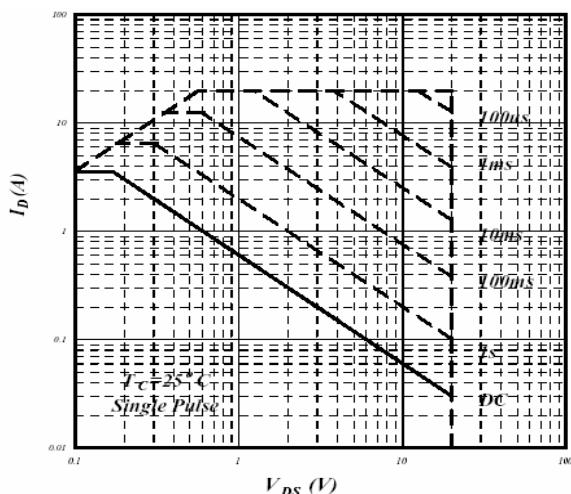


Fig 9. Maximum Safe Operating Area

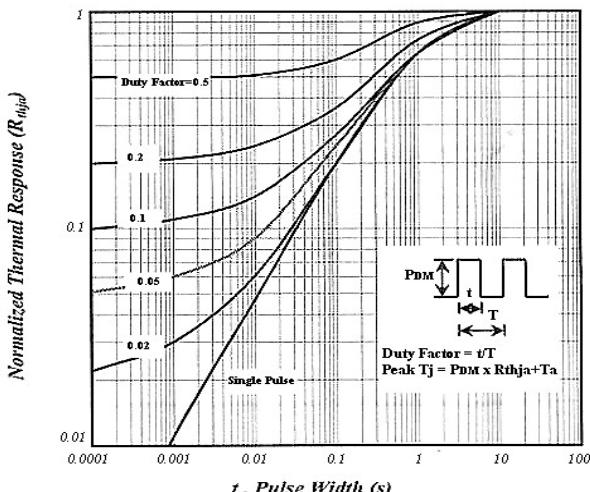


Fig 10. Effective Transient Thermal Impedance

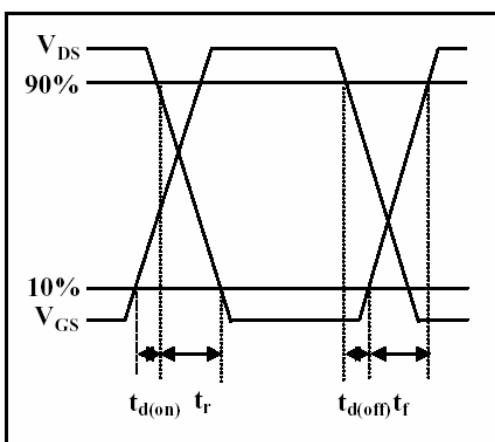


Fig 11. Switching Time Waveform

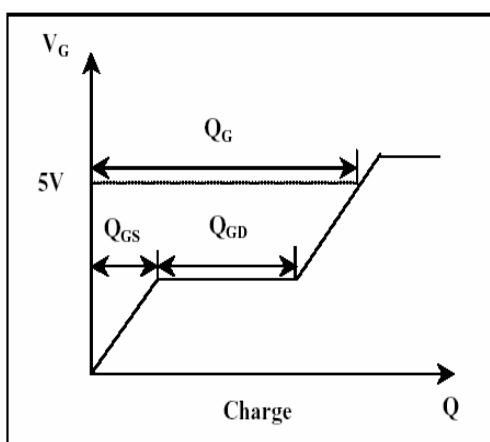


Fig 12. Gate Charge Waveform

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